

Automotive-grade N-channel 600 V, 0.037  $\Omega$  typ., 66 A  
MDmesh™ DM2 Power MOSFET in a TO-247 package

Datasheet - production data

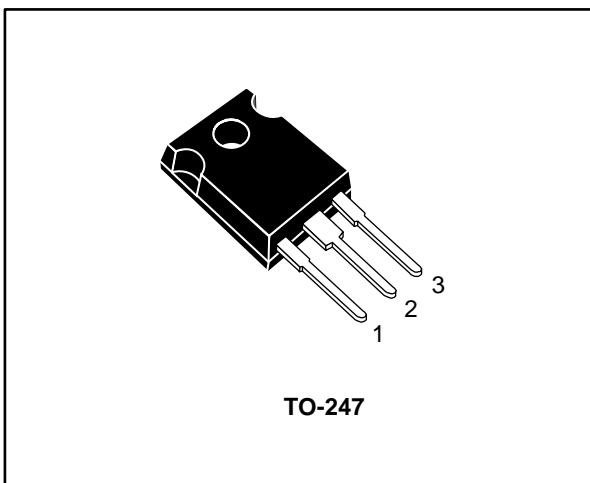
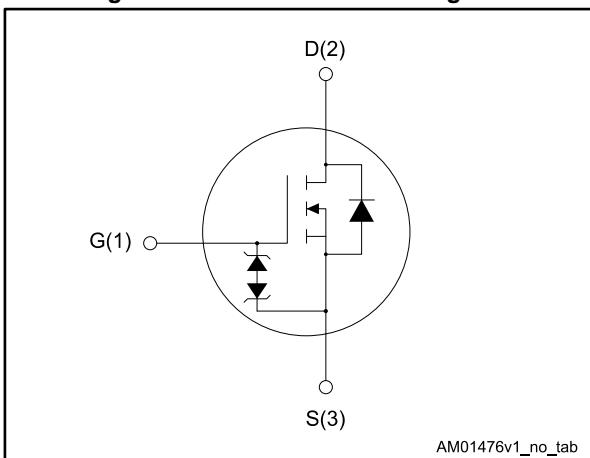


Figure 1: Internal schematic diagram



## Features

Order code	$V_{DS}$	$R_{DS(on)}$ max.	$I_D$	$P_{TOT}$
STW72N60DM2AG	600 V	0.042 $\Omega$	66 A	446 W

- Designed for automotive applications and AEC-Q101 qualified
- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

## Applications

- Switching applications

## Description

This high voltage N-channel Power MOSFET is part of the MDmesh™ DM2 fast recovery diode series. It offers very low recovery charge ( $Q_{rr}$ ) and time ( $t_{rr}$ ) combined with low  $R_{DS(on)}$ , rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STW72N60DM2AG	72N60DM2	TO-247	Tube

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# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate-source voltage	$\pm 25$	V
$I_D$	Drain current (continuous) at $T_{case} = 25^\circ\text{C}$	66	A
	Drain current (continuous) at $T_{case} = 100^\circ\text{C}$	42	
$I_{DM}^{(1)}$	Drain current (pulsed)	264	A
$P_{TOT}$	Total dissipation at $T_{case} = 25^\circ\text{C}$	446	W
$dv/dt^{(2)}$	Peak diode recovery voltage slope	50	V/ns
$dv/dt^{(3)}$	MOSFET dv/dt ruggedness	50	
$T_{stg}$	Storage temperature	-55 to 150	$^\circ\text{C}$
$T_j$	Maximum junction temperature	150	

**Notes:**

(1) Pulse width is limited by safe operating area.

(2)  $I_{SD} \leq 66$  A,  $di/dt=800$  A/ $\mu\text{s}$ ;  $V_{DS}$  peak <  $V_{(BR)DSS}$ ,  $V_{DD} = 80\%$   $V_{(BR)DSS}$ .(3)  $V_{DS} \leq 480$  V.

Table 3: Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	0.28	$^\circ\text{C}/\text{W}$
$R_{thj-amb}$	Thermal resistance junction-ambient	50	

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not repetitive (Pulse width limited by $T_{jmax}$ )	10	A
$E_{AR}$	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50$ V)	1500	mJ

## 2 Electrical characteristics

( $T_{case} = 25^\circ C$  unless otherwise specified)

**Table 5: Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 1 mA$	600			V
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 600 V$			10	$\mu A$
		$V_{GS} = 0 V, V_{DS} = 600 V, T_{case} = 125^\circ C$			100	
$I_{GSS}$	Gate-body leakage current	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			$\pm 5$	$\mu A$
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3	4	5	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10 V, I_D = 33 A$		0.037	0.042	$\Omega$

**Table 6: Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 100 V, f = 1 MHz, V_{GS} = 0 V$	-	5508	-	$pF$
$C_{oss}$	Output capacitance		-	241	-	
$C_{rss}$	Reverse transfer capacitance		-	2.8	-	
$C_{oss\ eq.}\text{ (1)}$	Equivalent output capacitance	$V_{DS} = 0$ to $480 V, V_{GS} = 0 V$	-	470	-	$pF$
$R_G$	Intrinsic gate resistance	$f = 1 MHz, I_D = 0 A$	-	2	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 480 V, I_D = 66 A, V_{GS} = 10 V$ (see <i>Figure 15: "Gate charge test circuit"</i> )	-	121	-	$nC$
$Q_{gs}$	Gate-source charge		-	26	-	
$Q_{gd}$	Gate-drain charge		-	61	-	

**Notes:**

(1)  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

**Table 7: Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 300 V, I_D = 33 A$ $R_G = 4.7 \Omega, V_{GS} = 10 V$ (see <i>Figure 14: "Switching times test circuit for resistive load"</i> and <i>Figure 19: "Switching time waveform"</i> )	-	32	-	$ns$
$t_r$	Rise time		-	67	-	
$t_{d(off)}$	Turn-off delay time		-	112	-	
$t_f$	Fall time		-	10.4	-	

Table 8: Source-drain diode

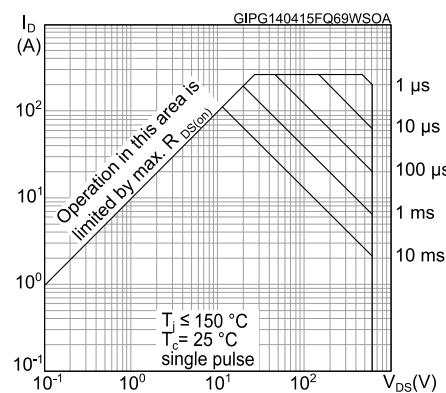
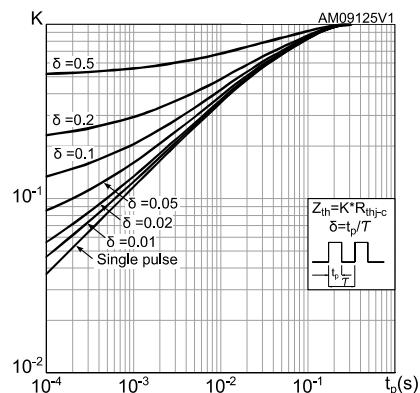
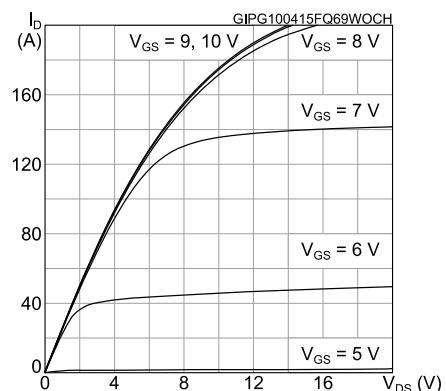
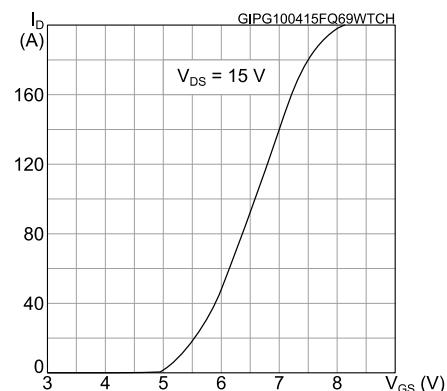
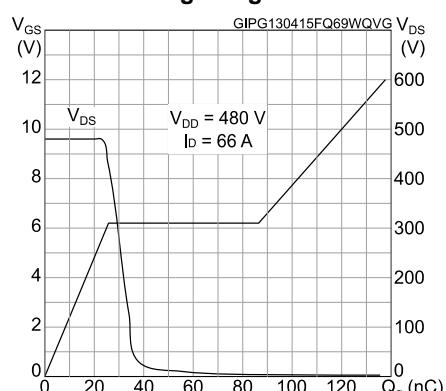
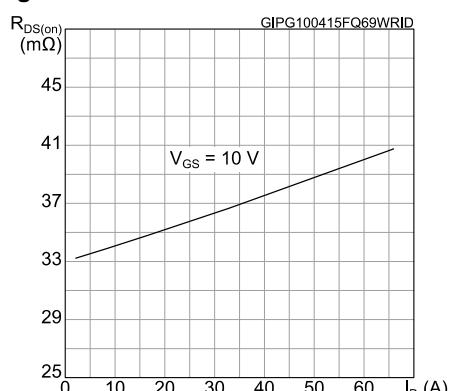
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		66	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		264	A
$V_{SD}^{(2)}$	Forward on voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 66 \text{ A}$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 66 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 60 \text{ V}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> )	-	150		ns
$Q_{rr}$	Reverse recovery charge		-	0.75		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	10.5		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 66 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 60 \text{ V}, T_j = 150 \text{ }^\circ\text{C}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> )	-	250		ns
$Q_{rr}$	Reverse recovery charge		-	2.5		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	20.7		A

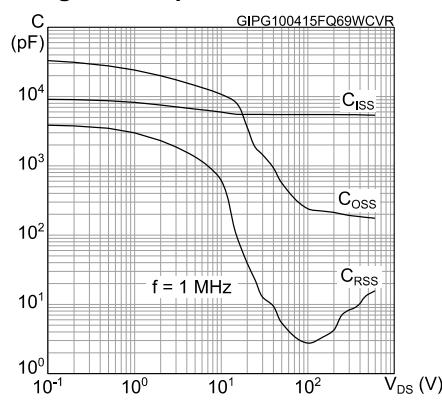
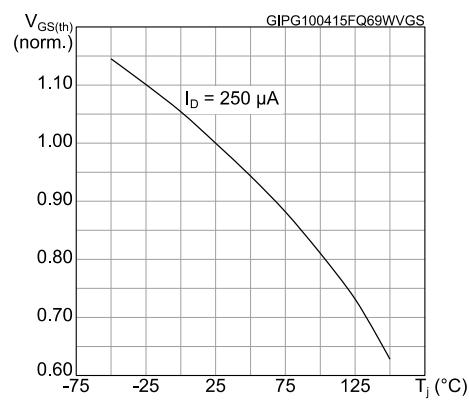
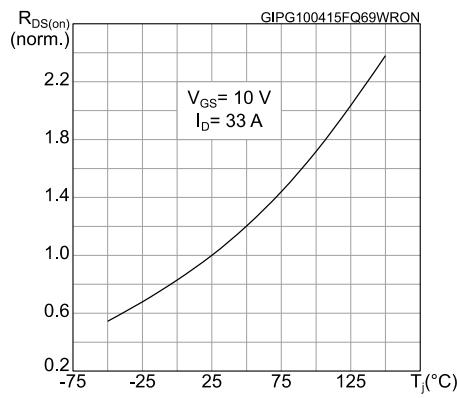
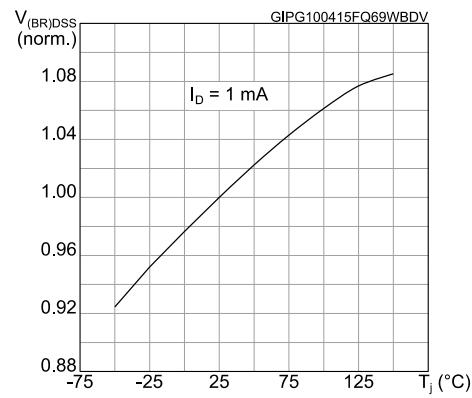
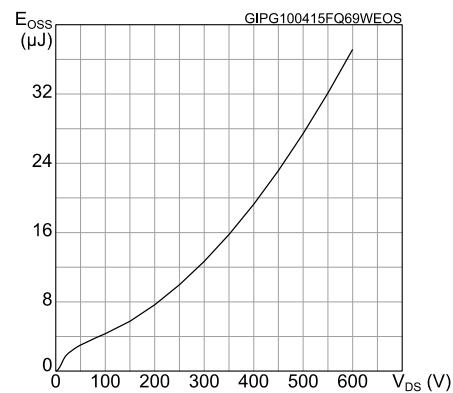
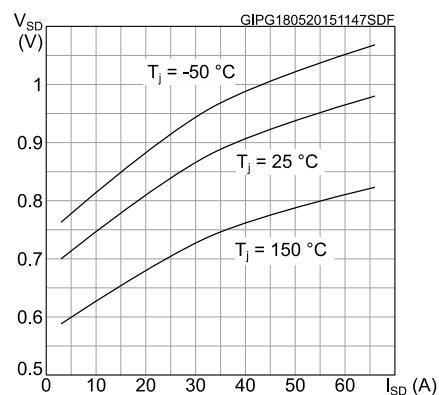
**Notes:**

(1) Pulse width is limited by safe operating area.

(2) Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

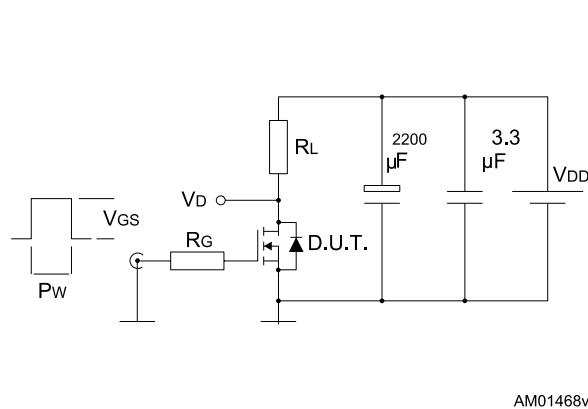
## 2.1 Electrical characteristics (curves)

**Figure 2: Safe operating area****Figure 3: Thermal impedance****Figure 4: Output characteristics****Figure 5: Transfer characteristics****Figure 6: Gate charge vs gate-source voltage****Figure 7: Static drain-source on-resistance**

**Figure 8: Capacitance variations****Figure 9: Normalized gate threshold voltage vs temperature****Figure 10: Normalized on-resistance vs temperature****Figure 11: Normalized V(BR)DSS vs temperature****Figure 12: Output capacitance stored energy****Figure 13: Source- drain diode forward characteristics**

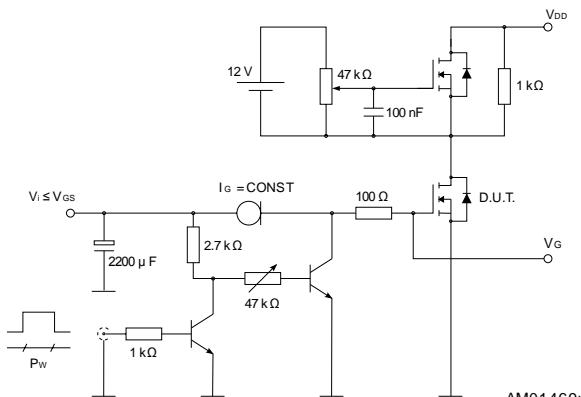
### 3 Test circuits

**Figure 14: Switching times test circuit for resistive load**



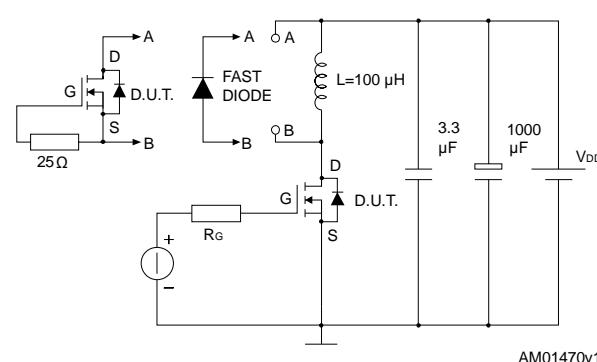
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**Figure 15: Gate charge test circuit**



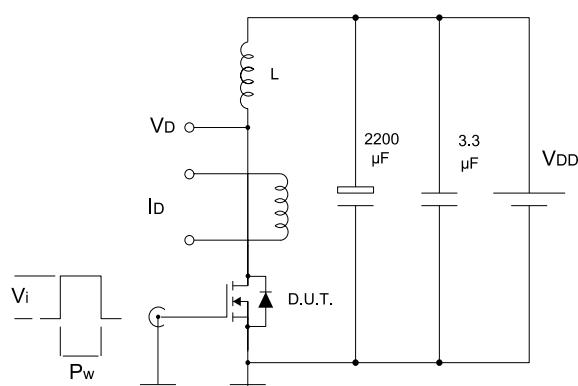
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**Figure 16: Test circuit for inductive load switching and diode recovery times**



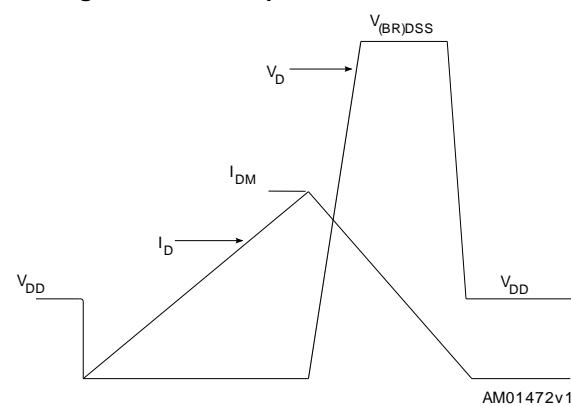
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**Figure 17: Unclamped inductive load test circuit**



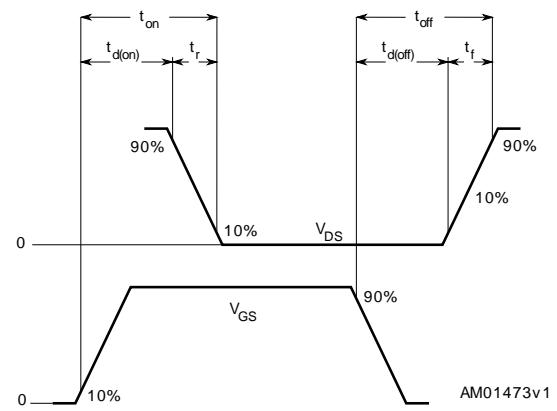
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**Figure 18: Unclamped inductive waveform**



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**Figure 19: Switching time waveform**



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## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

### 4.1 TO-247 package information

Figure 20: TO-247 package outline

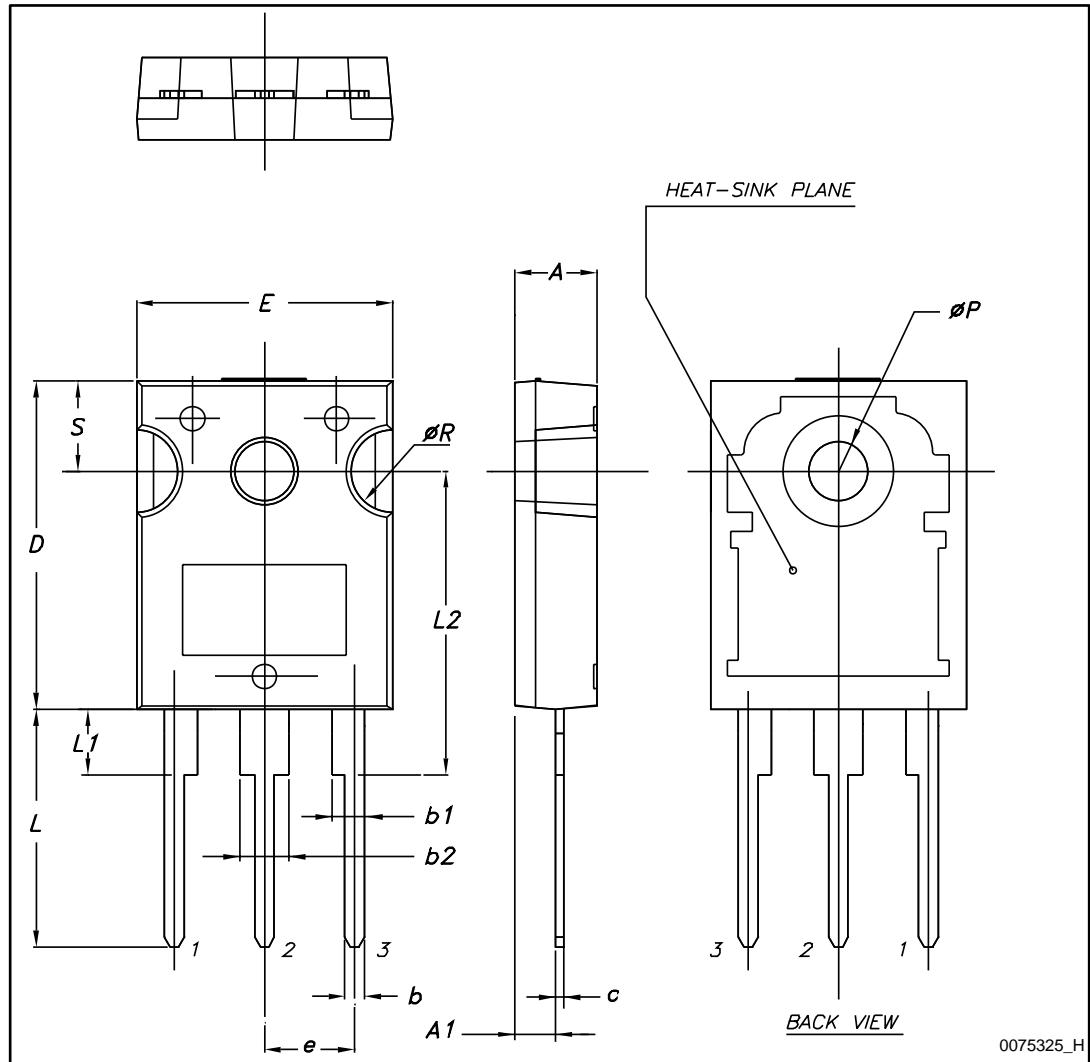


Table 9: TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

## 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
27-Jan-2015	1	First release.
14-Apr-2015	2	Text edits and formatting changes throughout document Removed TO-247 long leads package data Added Section 2.1 Electrical characteristics (curves)
01-Jul-2015	3	Text edits and formatting changes throughout document On cover page: - updated title and features In Section Electrical ratings: - updated Table Absolut maximum ratings In Section Electrical characteristics: - updated Tables Static, Dynamic, Switching times and Source-drain diode Updated Section Electrical characteristics (curves)

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